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<u>REVISION:</u> B	ECR/ECN INFORMATION: EC No: SH2007-0375 DATE: 2006/12/04	USB A	SINK REVERSE ead - Free Version	TYPE າ)	<u>SHEET No.</u> 2 of 8
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P	S-48258-001	Tom YU	Bosana Kang	Alle	en Lin
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USB A SINK REVERSE TYPE

1.0 SCOPE

This specification covers the requirements for product performance and test methods of USB A SINK REVERSE TYPE Connector.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER(S)

2.1.1 PRODUCT NAME: USB A SINK REVERSE TYPE 2.1.2 SERIES NUMBER: 48258-XXXX

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See drawing No: SD-48258-001

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

EIA-364. MIL-STD-202. MIL-STD-1344A. USB 2.0 SPECIFICATIONS

4.0 RATINGS

4.1 VOLTAGE 250 Volts AC (RMS)

4.2 CURRENT

1.5 Amps

4.3 TEMPERATURE

Operating Temperature: -25°C to +85°C Stock Temperature: -25°C to +100°C

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5.0 PERFORMANCE

5.1 APPEARANCE REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Examination of Product	EIA-364-18 Visual inspection	Meets requirements of product drawing. No physical damage.

5.2 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
2	Low Level Contact Resistance	EIA 364-23 Mate connectors: apply a maximum voltage of 20 mV and a current of 100 mA.	30 milliohms MAXIMUM
3	Insulation Resistance	EIA 364-21 Unmate & unmount connectors: apply a voltage of 500 VDC between adjacent terminals and between terminals to ground.	1000 Megohms MINIMUM
4	Dielectric Withstanding Voltage	EIA 364-20 Unmate connectors: apply a voltage of 500 volts VAC for 1 minute between adjacent terminals and between terminals to ground.	No breakdown; current leakage < 0.5 mA
5	Contact Capacitance	EIA-364-30 Test between adjacent circuits of unmated connector at 1 KHz. The object of this test is to detail a standard method to determine the capacitance between conductive elements of a USB connector.	2 pF Maximum per Contact

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		EIA 364-70 Method B	
		When measured at an ambient	
		temperature of 25°C. With Power applied	
	to the contacts, the ΔT shall not exceed +		
c	6 Contact Current Rating	applied to the contacts, the 30 $^\circ\!\mathrm{C}$ at any	1.5A at 250Vac minimum &
0		point in the USB connector under test	Temperature rise:
	The object of this test procedure is to	+30°C MAXIMUM	
		detail a standard method to assess the	
	current caring capacity of mated USB		
		connector contacts.	

5.3 MECHANICAL REQUIREMENTS (continued)

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
Connector Mate 7 and Unmate Forces	Connector Mate	EIA 364-13 Mate and unmate connector (male to	Mating Force : 35 N MAXIMUM
	female) at maximum a rate of 12.5 mm (0.492 inch) per minute.	Unmating Force : 10 N MINIMUM	
8	Durability	EIA-364-09 Mate and unmate Connector assemblies for 1500 cycles at maximum rated of 200 cycles per hour.	1) Shall meet visual requirement, show no physical damage
			Mating Force : 35 N MAXIMUM Unmating Force : 10 N MINIMUM 1) Shall meet visual requirement, show no physical damage 2) 30 milliohms MAXIMUM 1).No discontinuities of 1 us microsecond or longer duration 2).Shall meet visual requirement, show no physical damage. 3) 30 milliohms MAXIMUM
9	Vibration (Random)	EIA-364-28 Test Condition V Test Letter A. Mate connectors and subject to 5.35 Gs RMS. For a period of 15 minutes in each of 3 mutually perpendicular axes.	 No discontinuities of 1 us microsecond or longer duration Shall meet visual requirement, show no physical damage. 30 milliohms MAXIMUM

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10	Mechanical Shock	EIA 364-27 Test Condition H Subject mated connectors to 30G's half- sine shock pulses of 11ms duration. Three shocks in each direction applied along three mutually perpendicular planes, 18 total shock.	 No discontinuities of 1 us microsecond or longer duration Shall meet visual requirement, show no physical damage. 30 milliohms MAXIMUM
11	Cable Pull-out Force	EIA 364-38 Test condition A Shall be measured with TENSION GAUGE or TENSION TESTER in same direction.	40 Newtons to the connector for 1 minute.

5.4 ENVIRONMENTAL REQUIREMENTS

TEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
12	Humidity	EIA 364-31 Test condition A method III Subject mated connectors to Duration : 168 hours temperature between -25° C to +65°C with 90 to 95% RH	 Dielectric Withstanding Voltage: No Breakdown at 500 VAC Insulation Resistance: 1000 Megohms MINIMUM Visual: No Damage
13	Shock (Thermal)	EIA 364-32, Test Condition I Subject mated connectors to ten cycles between –55°C to +85°C.	 Dielectric Withstanding Voltage: No Breakdown at 500 VAC Insulation Resistance: 1000 Megohms MINIMUM Visual: No Damage
14	Temperature Life	EIA 364-17 Test Condition 2 Method A Subject mated connectors to temperature life at 85°C for 240hours	 30 milliohms MAXIMUM Shall meet visual requirement, show no physical damage.
15	Solderability	EIA 364-52 connector terminal tails in solder: (held at $245 \pm 5^{\circ}$ C) up to 0.5mm from the bottom of the housing for 5 ± 0.5 sec.	The surface of the portion to be soldered shall at least 95% covered with new solder coating

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6.0 PRODUCT QUALIFICATION AND REQUALIFICATION TEST SEQUENCE

TEST SEQUENCES IDENTIFICATION

Test Group						
Item	Test Description	А	В	С	D	Е
1	Examination of product	1,10	1,5	1,9	1,3	1,3
2	Low Level Contact Resistance	3,7	2,4			
3	Insulation Resistance			3,7		
4	Dielectric Withstanding Voltage			4,8		
5	Contact Capacitance			2		
6	Contact Current Rating					2
7	Mating & Unmating Force	2,8				
8	Durability	4				
9	Random Vibration	6				
10	Mechanical Shock	5				
11	Cable Pull-out Force					4
12	Humidity			5		
13	Thermal Shock			6		
14	Temperature Life		3			
15	Solderability				2	
16	Resistance to solder heat	9				
Number of Test Samples (Minimum)		5	5	5	5	5

Note:

- a. Samples shall be prepare in accordance with applicable manufacture's instructions and shall be selected at random from current production.
- b. Precondition samples with 3 cycles durability.
- c. All the tests shall be performed in the sequence.

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